

Supporting information, Figure S1

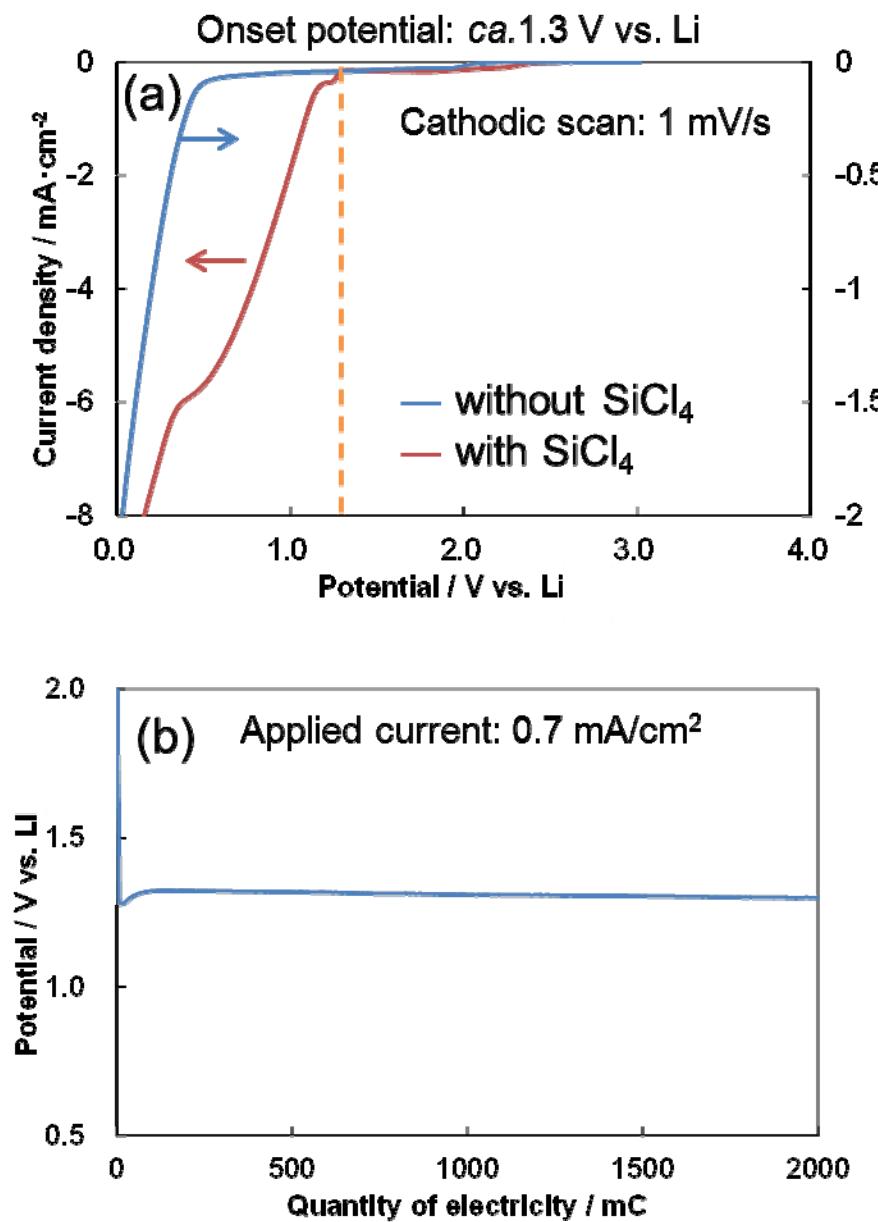


Fig. S1 (a) Linear sweep voltammogram measured with the electrochemical cell equipped with a Li reference electrode, a 1.00 cm^2 Cu foil as a working electrode and a Pt counter electrode in the electrolyte solution of 0.5 mol dm^{-3} SiCl_4 and 0.5 mol dm^{-3} TBAP in PC. (b) Chronopotentiogram during the electrodeposition of silicon measured with the above cell containing SiCl_4 .

Supporting information, Figure S2

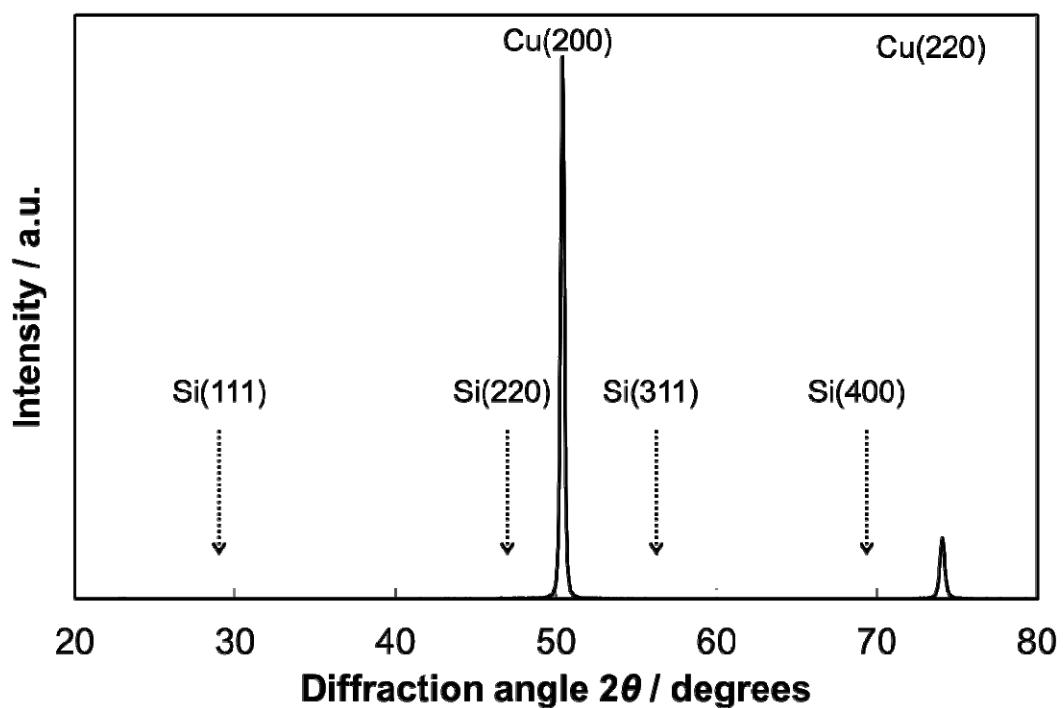


Fig. S2 XRD pattern of the deposit prepared by the electrodeposition of silicon. The dotted arrows indicate the positions of the peaks for silicon.

Supporting information, Figure S3

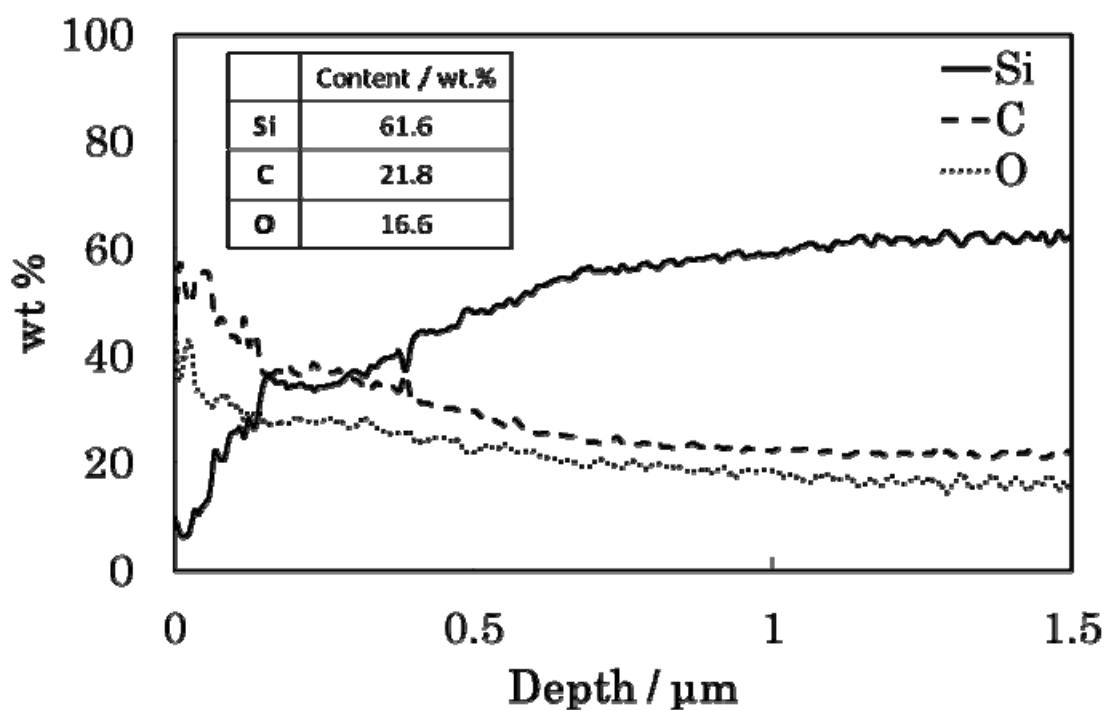


Fig. S3 GDOES depth profiles for the elements of Si, C, and O in the deposit, represented by solid line, dashed line, and dotted line, respectively. The inset indicates the composition by average weight at the depth of 1.0 to 1.5 μm .

Supporting information, Figure S4

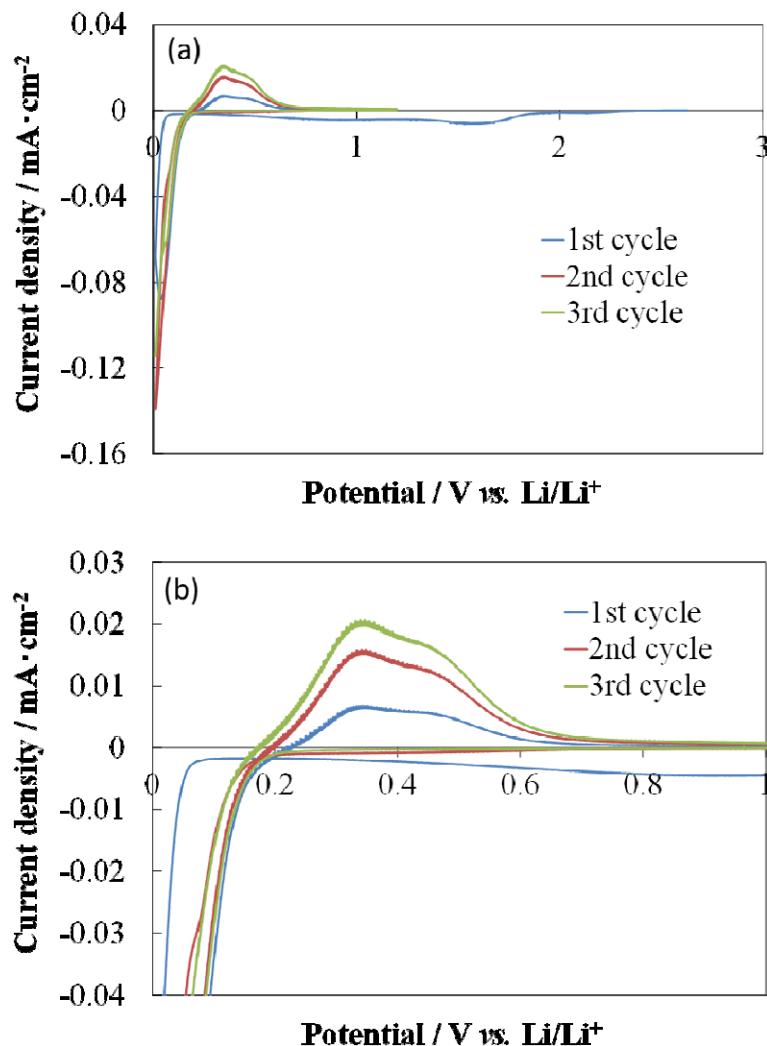


Fig. S4 Cyclic voltammogram of overall (a) and enlarged (b) measured with the electrochemical cell equipped with a Li/Li⁺ reference electrode, the SiOC composite electrode as a working electrode and a Li counter electrode in the electrolyte solution of 1 mol dm⁻³ LiClO₄ in EC-PC. The CV was measured between 0.01 and 1.2 V vs. Li/Li⁺ with the scan rate of 0.1 mV/sec.

The reductive current above *ca.* 0.4 V vs. Li/Li⁺ and below *ca.* 0.1 V vs. Li/Li⁺ which are attributable to side reactions like electrolyte decomposition and lithiation of SiOC electrode, respectively, were observed at the first cathodic scan. The oxidative current peaks at 0.32 and 0.46 V vs. Li/Li⁺ which correspond to delithiation of SiOC electrode were observed at anodic scan. The reductive current below *ca.* 0.2 V vs. Li/Li⁺ which is also attributable to lithiation of SiOC electrode.